

MOS FIELD EFFECT TRANSISTOR 2SK3634

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3634 is N-channel MOS FET device that features a low on-state resistance and excellent switching characteristics, and designed for high voltage applications such as DC/DC converter.

FEATURES

- High voltage: VDSS = 200 V
- Gate voltage rating: ±30 V
- $R_{DS(on)} = 0.60 \Omega MAX. (V_{GS} = 10 V, I_D = 3.0 A)$
- Low Ciss: Ciss = 270 pF TYP. (VDs = 10 V, VGs = 0 V)
- Built-in gate protection diode
- TO-251/TO-252 package
- Avalanche capability rated

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	/		
Drain to Source Voltage (Vgs = 0 V)	VDSS	200	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±30	V
Drain Current (DC) (Tc = 25°C)	D(DC)	±6.0	А
Drain Current (Pulse) Note1	D(pulse)	±18	А
Total Power Dissipation (Tc = 25°C)	Рт1	20	W
Total Power Dissipation (T _A = 25°C)	P T2	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
Single Avalanche Current Note2	las	6.0	А
Single Avalanche Energy Note2	Eas	3.6	mJ
Repetitive Avalanche Current Note3	IAR	6.0	А
Repetitive Pulse Avalanche Energy Note3	Ear	2.0	mJ

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3634	TO-251
2SK3634-Z	TO-252

(TO-251)



(TO-252)



Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

- 2. Starting T_{ch} = 25°C, V_{DD} = 100 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V, L = 100 μ H
- 3. $T_{ch} \leq 125^{\circ}C$, R_{G} = 25 $\Omega,$ V_{DD} = 100 V

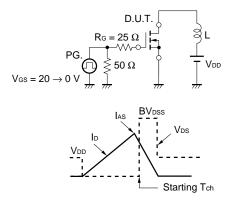
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ELECTRICAL CHARACTERISTICS (TA = 25°C)

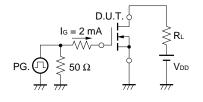
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	V _{DS} = 200 V, V _{GS} = 0 V			10	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Gate Cut-off Voltage	VGS(off)	V _{DS} = 10 V, I _D = 1 mA	2.5	3.5	4.5	V
Forward Transfer Admittance	yfs	Vds = 10 V, Id = 3.0 A	2	4		S
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Id = 3.0 A		0.47	0.60	Ω
Input Capacitance	Ciss	V _{DS} = 10 V		270		pF
Output Capacitance	Coss	Vgs = 0 V		75		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		33		pF
Turn-on Delay Time	td(on)	Vdd = 100 V, Id = 3.0 A		4		ns
Rise Time	tr	Vgs = 10 V		8		ns
Turn-off Delay Time	td(off)	R _G = 0 Ω		14		ns
Fall Time	tr			6		ns
Total Gate Charge	QG	V _{DD} = 160 V		9		nC
Gate to Source Charge	QGS	Vgs = 10 V		1.5		nC
Gate to Drain Charge	Qgd	ID = 6.0 A		4.5		nC
Body Diode Forward Voltage	VF(S-D)	IF = 16 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 6 A, VGS = 0 V		100		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		320		nC

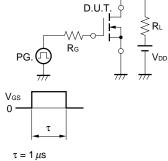
TEST CIRCUIT 1 AVALANCHE CAPABILITY

TEST CIRCUIT 2 SWITCHING TIME

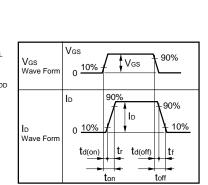


TEST CIRCUIT 3 GATE CHARGE

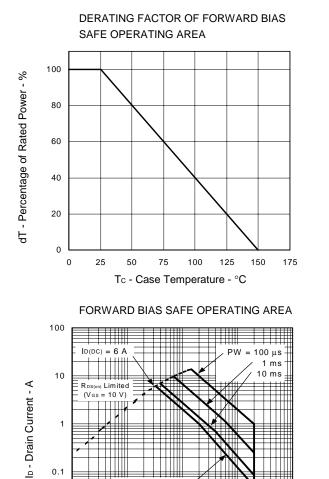




Duty Cycle $\leq 1\%$



TYPICAL CHARACTERISTICS (TA = 25°C)



Power Dissipation

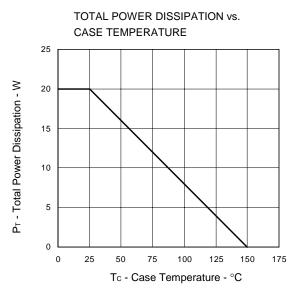
10

VDS - Drain to Source Voltage - V

100

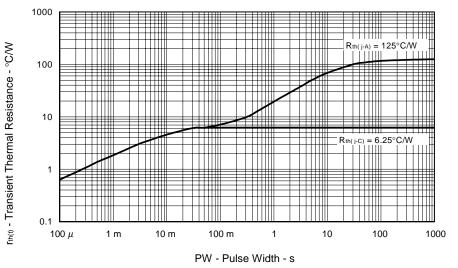
1

0.01 L 0.1

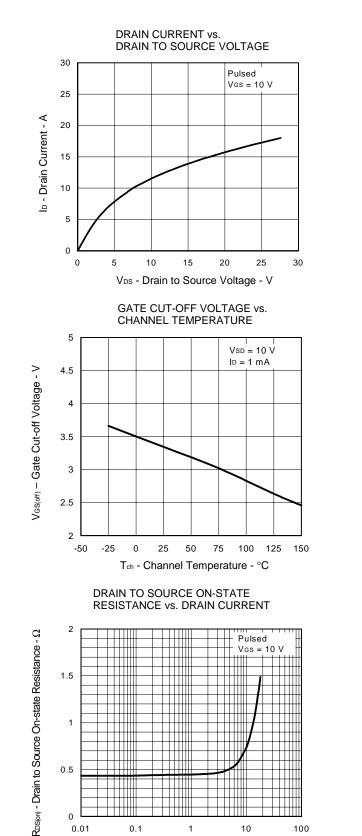


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

1000



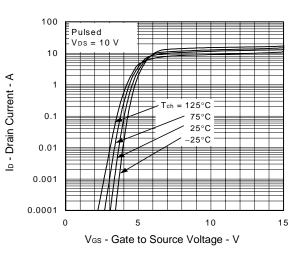
Data Sheet D15936EJ1V0DS



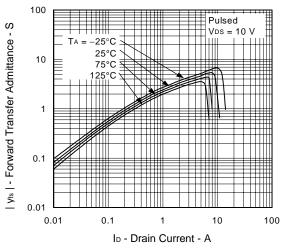
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ID - Drain Current - A

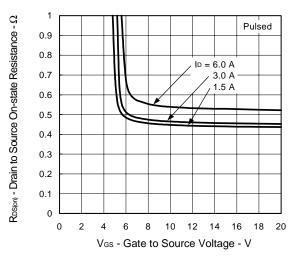
FORWARD TRANSFER CHARACTERISTICS

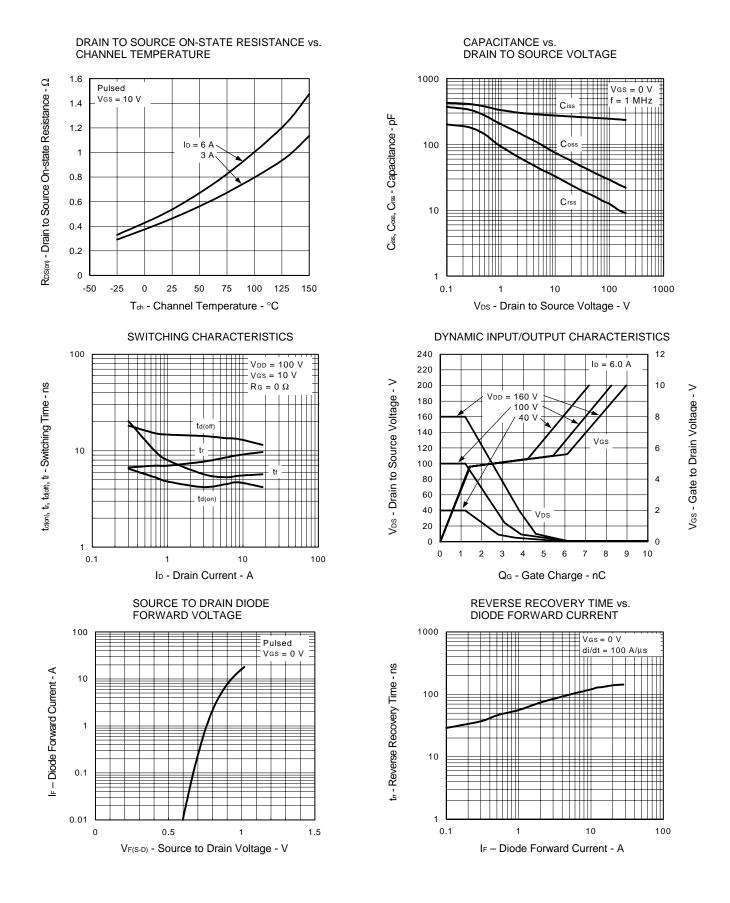


FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

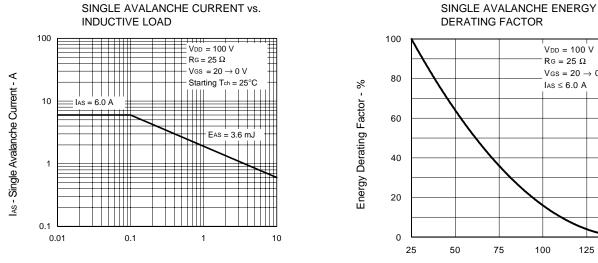


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

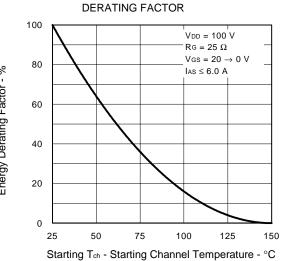




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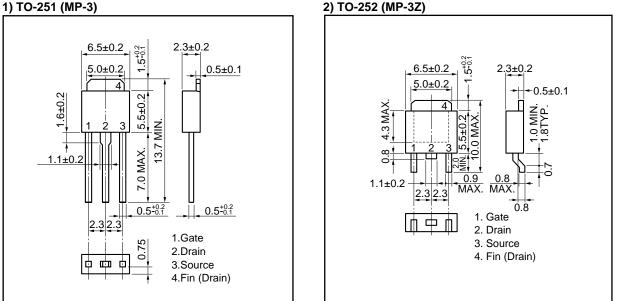


L - Inductive Load - mH

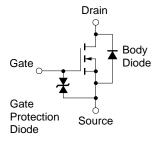


PACKAGE DRAWINGS (Unit: mm)

1) TO-251 (MP-3)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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